



RADIO TEST REPORT

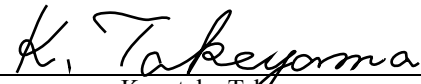
Test Report No. : 11822953S-A-R1

Applicant : Sony Corporation
Type of Equipment : Remote Control
Model No. : RMT-TX800
FCC ID : AK8RMTTX800
Test regulation : FCC Part 15 Subpart C: 2017
Test Result : Complied

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan has been accredited.
6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
7. This report is a revised version of 11822953S-A. 11822953S-A is replaced with this report.

Date of test: June 24 and 26, 2017

Representative test engineer:


Kazutaka Takeyama
Engineer
Consumer Technology Division

Approved by:


Toyokazu Imamura
Leader
Consumer Technology Division



- ☐ The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.
☒ There is no testing item of "Non-accreditation".

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13-EM-F0429

REVISION HISTORY

Original Test Report No.: 11822953S-A

[illegible]

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SECTION 1: Customer information

Company Name	:	Sony Corporation
Brand Name	:	SONY
Address	:	1-7-1 Konan, Minato-ku, Tokyo 108-0075, Japan

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	:	Remote Control
Model No.	:	RMT-TX800
Serial No.	:	Refer to Section 4, Clause 4.2
Rating	:	DC 3 V
Receipt Date of Sample	:	June 12, 2017
Country of Mass-production	:	China
Condition of EUT	:	Production prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No Modification by the test lab.

2.2 Product Description

Model: RMT-TX800 (referred to as the EUT in this report) is a Remote Control.

General Specification

Clock frequency(ies) in the system	:	32.768 kHz, 16 MHz
------------------------------------	---	--------------------

Radio Specification

Radio Type	:	Transceiver
Frequency of Operation	:	2402 MHz - 2480 MHz
Modulation	:	GFSK
Power Supply (radio part input)	:	DC 3 V
Antenna type	:	Chip
Antenna Gain	:	2.5 dBi

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC Part 15 final revised on June 14, 2017 and effective July 14, 2017

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928MHz,
2400-2483.5MHz, and 5725-5850MHz

* The revision on June 14, 2017, does not affect the test specification applied to the EUT.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.10-2013 6. Standard test methods IC: RSS-Gen 8.8	FCC: Section 15.207 IC: RSS-Gen 8.8	-	-	N/A *1)
6dB Bandwidth	FCC: KDB 558074 D01 DTS Meas Guidance v04 IC: -	FCC: Section 15.247(a)(2) IC: RSS-247 5.2(a)	See data.	Complied	Conducted
Maximum Peak Output Power	FCC: KDB 558074 D01 DTS Meas Guidance v04 IC: RSS-Gen 6.12	FCC: Section 15.247(b)(3) IC: RSS-247 5.4(d)		Complied	Conducted
Power Density	FCC: KDB 558074 D01 DTS Meas Guidance v04 IC: -	FCC: Section 15.247(e) IC: RSS-247 5.2(b)		Complied	Conducted
Spurious Emission Restricted Band Edges	FCC: KDB 558074 D01 DTS Meas Guidance v04 IC: RSS-Gen 6.13	FCC: Section 15.247(d) IC: RSS-247 5.5 RSS-Gen 8.9 RSS-Gen 8.10	2.2 dB 4960.000 MHz, AV, Horizontal, Tx 2480 MHz	Complied	Conducted (below 30 MHz)/ Radiated (above 30 MHz) *2)

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) The test is not applicable since the EUT has no AC mains.

*2) Radiated test was selected over 30 MHz based on section 15.247(d) and KDB 558074 D01 DTS Meas Guidance v04 12.2.7.

* In case any questions arise about test procedure, ANSI C63.10: 2013 is also referred.

FCC Part 15.31 (e)

The test was performed with the new battery and the stable voltage was supplied to the EUT during the tests.
Therefore, the EUT complies with the requirement.

FCC Part 15.203

It is impossible for end users to replace the antenna, because it is mounted inside of the EUT. Therefore the equipment complies with the requirement.

3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99 % Occupied Bandwidth	IC: RSS-Gen 6.6	IC: -	N/A	-	Conducted

Other than above, no addition, exclusion nor deviation has been made from the standard.

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3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k=2$.

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Item	Frequency range	Uncertainty (+/-)				
		No. 1 SAC / SR	No. 2 SAC / SR	No. 3 SAC / SR	No. 4 SAC / SR	No. 5,6,8 SR
Conducted emission (AC Mains) LISN	150 kHz-30 MHz	2.6 dB	2.5 dB	2.6 dB	2.5 dB	2.5 dB
Radiated emission (Measurement distance: 3 m)	9 kHz-30 MHz	3.1 dB	3.1 dB	3.1 dB	-	-
	30 MHz-200 MHz	4.6 dB	4.4 dB	4.6 dB	-	-
	200 MHz-1 GHz	5.8 dB	5.7 dB	5.8 dB	-	-
	1 GHz-13 GHz	4.9 dB	4.9 dB	4.9 dB	-	-
Radiated emission (Measurement distance: 1 m)	13 GHz-18 GHz	4.6 dB	4.6 dB	4.6 dB	-	-
	18 GHz-40 GHz	4.9 dB	4.9 dB	4.9 dB	-	-

SAC=Semi-Anechoic Chamber

SR= Shielded Room is applied besides radiated emission

Antenna terminal test	Uncertainty (+/-)
Power Measurement above 1 GHz (Average Detector)_SPM-06	0.72 dB
Power Measurement above 1 GHz (Peak Detector)_SPM-06	0.85 dB
Power Measurement above 1 GHz (Average Detector)_SPM-07	0.74 dB
Power Measurement above 1 GHz (Peak Detector)_SPM-07	0.91 dB
Spurious emission (Conducted) below 1GHz	1.6 dB
Spurious emission (Conducted) 1 GHz-3 GHz	1.3 dB
Spurious emission (Conducted) 3 GHz-18 GHz	2.2 dB
Spurious emission (Conducted) 18 GHz-26.5 GHz	2.3 dB
Spurious emission (Conducted) 26.5 GHz-40 GHz	2.4 dB
Bandwidth Measurement	1.01 %

Radiated emission test

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

3.5 Test Location

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JAB Accreditation No. RTL02610

Test site	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measurement distance
No.1 Semi-anechoic chamber	2973D-1	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.2 Semi-anechoic chamber	2973D-2	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.3 Semi-anechoic chamber	2973D-3	12.7 x 7.7 x 5.35	12.7 x 7.7	5 m
No.4 Semi-anechoic chamber	-	8.1 x 5.1 x 3.55	8.1 x 5.1	-
No.1 Shielded room	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.2 Shielded room	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.3 Shielded room	-	6.3 x 4.7 x 2.7	6.3 x 4.7	-
No.4 Shielded room	-	4.4 x 4.7 x 2.7	4.4 x 4.7	-
No.5 Shielded room	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.6 Shielded room	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.8 shielded room	-	3.45 x 5.5 x 2.4	3.45 x 5.5	-
No.1 Measurement room	-	2.55 x 4.1 x 2.5	-	-

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

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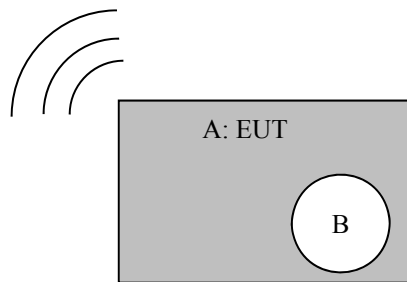
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SECTION 4: Operation of E.U.T. during testing

4.1 Operating Mode(s)

Mode	Frequency	Remarks*
Bluetooth Low Energy	2402 MHz, 2440 MHz, 2480 MHz	PN9
*Power of the EUT was set by the software as follows; - Power Setting: Fixed - Software: smartsnippets ver. 3.9 *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.		

4.2 Configuration and peripherals



* Test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remark
A	Remote Control	RMT-TX800	001 *1) 002 *2)	Sony Corporation	EUT
B	Battery	CR2032	-	Sony Corporation	3 V

*1) Used for Radiated emission tests

*2) Used for Antenna Terminal conducted test

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SECTION 5: Radiated Spurious Emission

Test Procedure

It was measured based on "11.0 Emissions in non-restricted frequency bands" of "KDB 558074 D01 DTS Meas Guidance v04".

[For below 1 GHz]

EUT was placed on a platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The height of the measuring antenna varied between 1 m and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

In any 100 kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20 dBc was applied to the frequency over the limit of FCC 15.209 / Table 4 of RSS-Gen 8.9(IC) and outside the restricted band of FCC15.205 / Table 6 of RSS-Gen 8.10 (IC).

Frequency	Below 1 GHz	Above 1 GHz		20 dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV *1)	PK
IF Bandwidth	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	Average Power Method: 12.2.5.2 RBW: 1 MHz VBW: 3 MHz Detector: Power Averaging (Linear voltage) Trace: 100 traces Duty factor was added to the results.	RBW: 100 kHz VBW: 300kHz
Test Distance	3 m	3.98 m *2) (1 GHz – 13 GHz), 1 m *3) (13 GHz – 26.5 GHz)		3.98 m *2) (1 GHz – 13 GHz), 1 m *3) (13 GHz – 26.5 GHz)

*1) Average Power Measurement was performed based on 6.0 & 12.2.5 of "KDB 558074 D01 DTS Meas Guidance v04".

*2) Distance Factor: $20 \times \log(3.98 \text{ m}/1.0 \text{ m}) = 2.45 \text{ dB}$

*3) Distance Factor: $20 \times \log(1.0 \text{ m}/3.0 \text{ m}) = -9.54 \text{ dB}$

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- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Antenna polarization	Frequency				
	Below 1 GHz	1 GHz - 2.8 GHz	2.8 GHz - 13 GHz	13 GHz - 18 GHz	18 GHz - 26.5 GHz
Horizontal	X	X	Y	X	X
Vertical	X	Z	Z	X	X

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 30 MHz - 26.5 GHz
Test data : APPENDIX
Test result : Pass

SECTION 6: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
6dB Bandwidth	10 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth *1)	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Sample	Max Hold	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak/Average *2)	-	Power Meter (Sensor: 50 MHz BW)
Peak Power Density	1.5 times the 6dB Bandwidth	3 kHz	9.1 kHz	Auto	Peak	Max Hold	Spectrum Analyzer *3)
Conducted Spurious Emission *4)	9kHz to 150kHz	200 Hz	620 Hz	Auto	Peak	Max Hold	Spectrum Analyzer
	150kHz to 30MHz	10 kHz	30 kHz				

*1) Peak hold was applied as Worst-case measurement.
 *2) Reference data
 *3) Section 10.2 Method PKPSD (peak PSD) of "KDB 558074 D01 DTS Meas Guidance v04".
 *4) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents.
 Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart.
 (9 kHz - 150 kHz: RBW = 200 Hz, 150 kHz - 30 MHz: RBW = 9.1 kHz)

The test results and limit are rounded off to two decimals place, so some differences might be observed.

Test data : APPENDIX
Test result : Pass

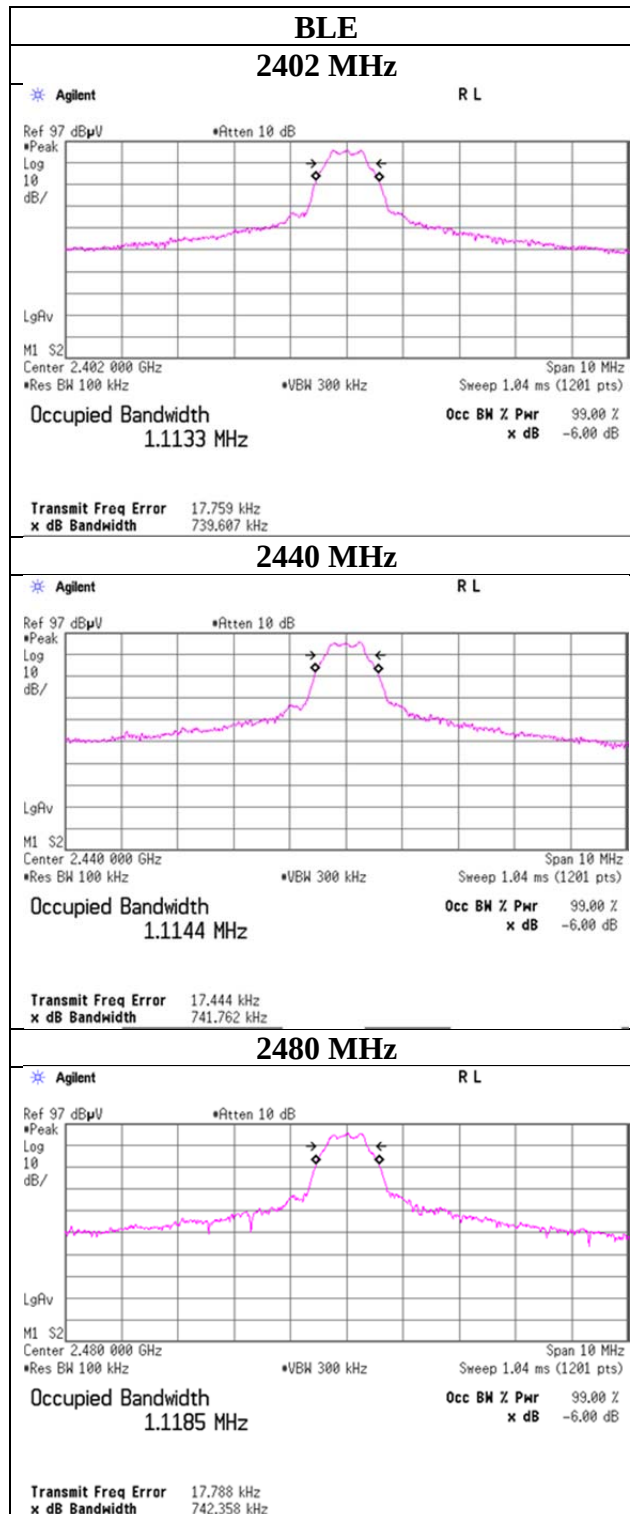
APPENDIX 1: Test data

6dB Bandwidth

Test place	Shonan EMC Lab. No.6 Shielded Room
Report No.	11822953S-A-R1
Date	June 26, 2017
Temperature / Humidity	23 deg. C / 53 % RH
Engineer	Kazutaka Takeyama
Mode	Tx

Mode	Frequency [MHz]	6dB Bandwidth [MHz]	Limit [kHz]
BLE	2402	0.740	> 500
	2440	0.742	> 500
	2480	0.742	> 500

6dB Bandwidth



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Maximum Peak Output Power

Test place Shonan EMC Lab. No.6 Shielded Room
Report No. 11822953S-A-R1
Date June 26, 2017
Temperature / Humidity 23 deg. C / 53 % RH
Engineer Kazutaka Takeyama
Mode Tx

Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
				[dBm]	[mW]	[dBm]	[mW]	
2402	-10.83	1.42	9.85	0.44	1.11	30.00	1000	29.56
2440	-11.05	1.43	9.84	0.22	1.05	30.00	1000	29.78
2480	-11.09	1.44	9.84	0.19	1.04	30.00	1000	29.81

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

*The equipment and cables were not used for factor 0 dB of the data sheets.

Average Output Power
(Reference data for RF Exposure)

Test place	Shonan EMC Lab. No.6 Shielded Room
Report No.	11822953S-A-R1
Date	June 26, 2017
Temperature / Humidity	23 deg. C / 53 % RH
Engineer	Kazutaka Takeyama
Mode	Tx

Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result (Time average)		Duty factor [dB]	Result (Burst power average)	
				[dBm]	[mW]		[dBm]	[mW]
2402	-15.87	1.42	9.85	-2.62	0.55	1.98	-0.64	0.86
2440	-16.20	1.43	9.84	-2.95	0.51	1.98	-0.97	0.80
2480	-16.10	1.44	9.84	-2.84	0.52	1.98	-0.86	0.82

Sample Calculation:

Result (Time average) = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

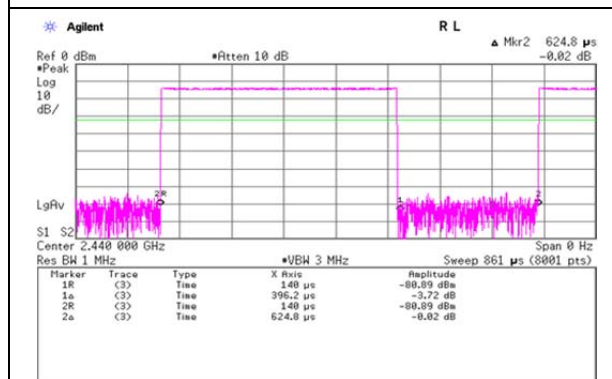
Result (Burst power average) = Time average + Duty factor

*The equipment and cables were not used for factor 0 dB of the data sheets.

Burst rate confirmation

Test place Shonan EMC Lab. No.6 Shielded Room
Report No. 11822953S-A-R1
Date June 26, 2017
Temperature / Humidity 23 deg. C / 53 % RH
Engineer Kazutaka Takeyama
Mode Tx

$Tx\ on / (Tx\ on + Tx\ off) = 0.634$
 $Tx\ on / (Tx\ on + Tx\ off) * 100 = 63.4\ \%$
 $Duty\ factor = 10 * \log (0.0006248 / 0.0003962) = 1.98\ dB$
 $Duty\ factor = 20 * \log (0.0006248 / 0.0003962) = 3.96\ dB$



* Since the burst rate is not different between the channels, the data has been obtained on the representative channel.

Radiated Spurious Emission

Test place : Shonan EMC Lab. No.1 & 3 Semi Anechoic Chamber
Report No. : 11822953S-A-R1
Date : June 24, 2017 June 26, 2017
Temperature / Humidity : 23 deg. C / 59 % RH 24 deg. C / 68 % RH
Engineer : Hiroyuki Morikawa Yosuke Ishikawa
(1 GHz -18 GHz) (18 GHz -26.5 GHz, 30 MHz – 1 GHz)
Mode : Tx BT LE 2402 MHz

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Distance Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg]	Remark
Hori.	51.133	QP	22.97	10.39	6.95	32.12	0.00	8.19	40.00	31.8	100	0	
Hori.	126.160	QP	22.74	13.29	7.49	32.05	0.00	11.47	43.50	32.0	100	0	
Hori.	167.790	QP	22.33	15.74	8.02	32.02	0.00	14.07	43.50	29.4	100	0	
Hori.	294.602	QP	22.15	13.21	8.69	31.92	0.00	12.13	46.00	33.8	100	0	
Hori.	2390.000	PK	52.90	27.21	14.05	40.85	2.45	55.76	73.90	18.1	100	146	
Hori.	4804.000	PK	50.50	31.13	6.38	41.86	2.45	48.60	73.90	25.3	100	128	
Hori.	7206.000	PK	46.82	36.24	8.00	41.18	2.45	52.33	73.90	21.6	150	0	
Hori.	9608.000	PK	45.14	38.13	9.29	40.59	2.45	54.42	73.90	19.5	150	0	
Vert.	154.844	QP	22.65	15.11	7.99	32.03	0.00	13.72	43.50	29.7	100	0	
Vert.	312.408	QP	22.11	13.67	8.78	31.90	0.00	12.66	46.00	33.3	100	0	
Vert.	608.302	QP	21.70	19.00	10.05	31.82	0.00	18.93	46.00	27.0	100	0	
Vert.	2390.000	PK	52.31	27.21	14.05	40.85	2.45	55.17	73.90	18.7	150	167	
Vert.	4804.000	PK	50.29	31.13	6.38	41.86	2.45	48.39	73.90	25.5	150	273	
Vert.	7206.000	PK	45.95	36.24	8.00	41.18	2.45	49.01	73.90	24.8	150	0	
Vert.	9608.000	PK	44.56	38.13	9.29	40.59	2.45	51.39	73.90	22.5	150	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18 GHz)) - Gain(Amplifier) + Distance factor

Distance factor : 1 GHz - 13 GHz : 20log (3.98 m / 3.0 m) = 2.45 dB

13 GHz - 40 GHz : 20log (1.0 m / 3.0 m) = -9.54 dB

Average measurement value with duty factor

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Distance Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2390.000	AV	37.51	27.21	14.05	40.85	3.96	2.45	44.33	53.90	9.6	*1)
Hori.	4804.000	AV	43.20	31.13	6.38	41.86	3.96	2.45	45.26	53.90	8.6	
Hori.	7206.000	AV	38.46	36.24	8.00	41.18	3.96	2.45	47.93	53.90	6.0	
Hori.	9608.000	AV	36.55	38.13	9.29	40.59	3.96	2.45	49.79	53.90	4.1	
Vert.	2390.000	AV	37.60	27.21	14.05	40.85	3.96	2.45	44.42	53.90	9.5	*1)
Vert.	4804.000	AV	42.31	31.13	6.38	41.86	3.96	2.45	44.37	53.90	9.5	
Vert.	7206.000	AV	38.20	36.24	8.00	41.18	3.96	2.45	47.67	53.90	6.2	
Vert.	9608.000	AV	36.62	38.13	9.29	40.59	3.96	2.45	49.86	53.90	4.0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18 GHz)) - Gain(Amplifier) + Duty factor + Distance factor

Distance factor : 1 GHz - 13 GHz : 20log (3.98 m / 3.0 m) = 2.45 dB

13 GHz - 40 GHz : 20log (1.0 m / 3.0 m) = -9.54 dB

Duty factor refer to "Duty factor Calculation chart" sheet.

*1) Not out of band emission (Leakage Power)

20 dBc Data Sheet (RBW 100 kHz, VBW 300 kHz)

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Distance Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2402.000	PK	86.94	27.25	14.06	40.84	2.45	89.86	-	-	Carrier
Hori.	2400.000	PK	49.54	27.25	14.06	40.84	2.45	52.46	69.86	17.4	
Vert.	2402.000	PK	85.88	27.25	14.06	40.84	2.45	88.80	-	-	Carrier
Vert.	2400.000	PK	48.97	27.25	14.06	40.84	2.45	51.89	68.80	16.9	

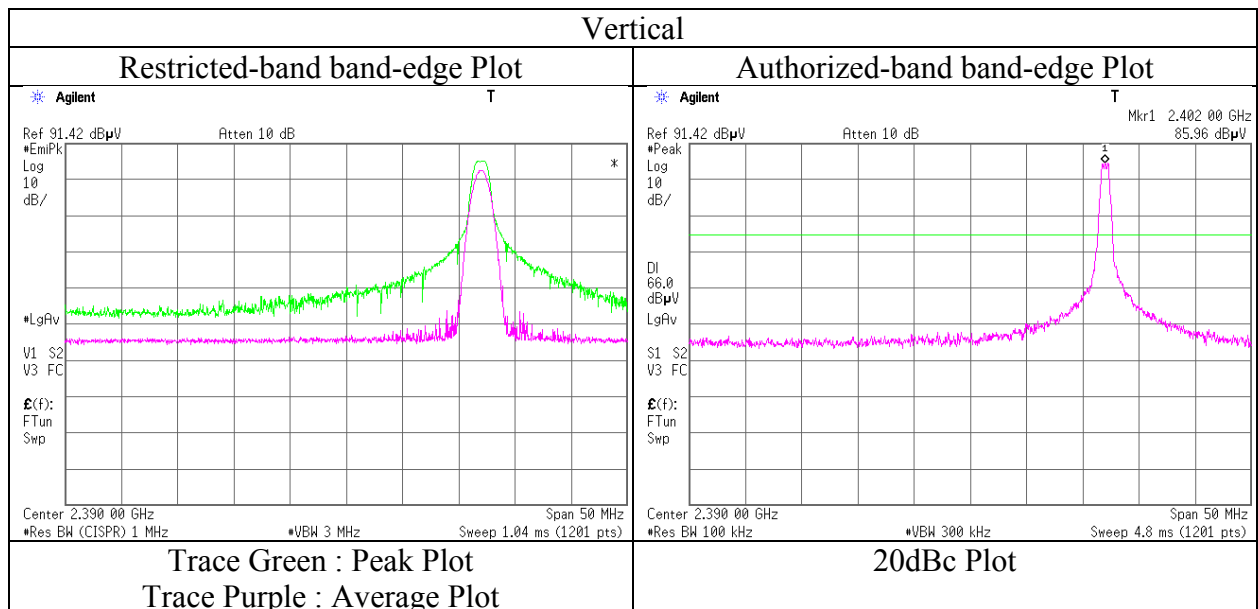
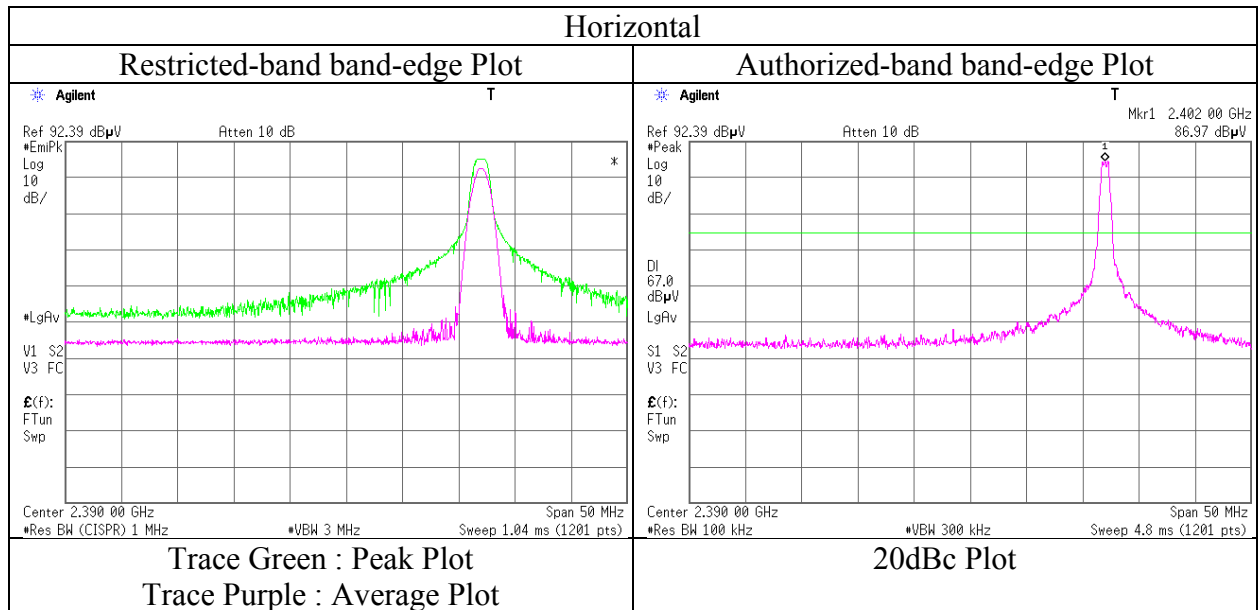
Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18 GHz)) - Gain(Amplifier) + Distance factor

Distance factor : 1 GHz - 13 GHz : 20log (3.98 m / 3.0 m) = 2.45 dB

13 GHz - 40 GHz : 20log (1.0 m / 3.0 m) = -9.54 dB

Radiated Spurious Emission (Reference Plot for band-edge)

Test place	Shonan EMC Lab. No.1 Semi Anechoic Chamber
Report No.	11822953S-A-R1
Date	June 24, 2017
Temperature / Humidity	23 deg. C / 59 % RH
Engineer	Hiroyuki Morikawa (1 GHz -13 GHz)
Mode	Tx BT LE 2402 MHz



* Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission

Test place : Shonan EMC Lab. No.1 & 3 Semi Anechoic Chamber
Report No. : 11822953S-A-R1
Date : June 24, 2017 June 26, 2017
Temperature / Humidity : 23 deg. C / 59 % RH 24 deg. C / 68 % RH
Engineer : Hiroyuki Morikawa Yosuke Ishikawa
(1 GHz -18 GHz) (18 GHz -26.5 GHz, 30 MHz – 1 GHz)
(1AC) (3AC)
Mode : Tx BT LE 2440 MHz

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Distance Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg]	Remark
Hori.	50.538	QP	22.89	10.56	6.95	32.12	0.00	8.28	40.00	31.7	100	0	
Hori.	126.223	QP	22.60	13.29	7.49	32.05	0.00	11.33	43.50	32.1	100	0	
Hori.	166.512	QP	22.31	15.68	8.03	32.02	0.00	14.00	43.50	29.5	100	0	
Hori.	294.382	QP	22.12	13.20	8.69	31.92	0.00	12.09	46.00	33.9	100	0	
Hori.	4880.000	PK	51.26	31.29	6.45	41.76	2.45	49.69	73.90	24.2	122	72	
Hori.	7320.000	PK	45.95	36.40	8.13	41.27	2.45	51.66	73.90	22.2	150	0	
Hori.	9760.000	PK	44.47	38.35	9.36	40.62	2.45	54.01	73.90	19.9	150	0	
Vert.	156.254	QP	22.65	15.19	8.00	32.03	0.00	13.81	43.50	29.6	100	0	
Vert.	312.375	QP	22.06	13.67	8.78	31.90	0.00	12.61	46.00	33.3	100	0	
Vert.	608.809	QP	21.59	19.01	10.05	31.82	0.00	18.83	46.00	27.1	100	0	
Vert.	4880.000	PK	51.17	31.29	6.45	41.76	2.45	49.60	73.90	24.3	100	47	
Vert.	7320.000	PK	46.90	36.40	8.13	41.27	2.45	52.61	73.90	21.3	150	0	
Vert.	9760.000	PK	44.66	38.35	9.36	40.62	2.45	54.20	73.90	19.7	150	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18 GHz)) - Gain(Amplifier) + Distance factor

Distance factor : 1 GHz - 13 GHz : 20log (3.98 m / 3.0 m) = 2.45 dB

13 GHz - 40 GHz : 20log (1.0 m / 3.0 m) = -9.54 dB

Average measurement value with duty factor

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Distance Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	4880.000	AV	43.23	31.29	6.45	41.76	3.96	2.45	45.62	53.90	8.3	
Hori.	7320.000	AV	37.90	36.40	8.13	41.27	3.96	2.45	47.57	53.90	6.3	
Hori.	9760.000	AV	36.26	38.35	9.36	40.62	3.96	2.45	49.76	53.90	4.1	
Vert.	4880.000	AV	43.35	31.29	6.45	41.76	3.96	2.45	45.74	53.90	8.2	
Vert.	7320.000	AV	37.75	36.40	8.13	41.27	3.96	2.45	47.42	53.90	6.5	
Vert.	9760.000	AV	36.61	38.35	9.36	40.62	3.96	2.45	50.11	53.90	3.8	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18 GHz)) - Gain(Amplifier) + Duty factor + Distance factor

Distance factor : 1 GHz - 13 GHz : 20log (3.98 m / 3.0 m) = 2.45 dB

13 GHz - 40 GHz : 20log (1.0 m / 3.0 m) = -9.54 dB

Duty factor refer to "Duty factor Calculation chart" sheet.

Radiated Spurious Emission

Test place : Shonan EMC Lab. No.1 & 3 Semi Anechoic Chamber
Report No. : 11822953S-A-R1
Date : June 24, 2017 June 26, 2017
Temperature / Humidity : 23 deg. C / 59 % RH 24 deg. C / 68 % RH
Engineer : Hiroyuki Morikawa Yosuke Ishikawa
(1 GHz -18 GHz) (18 GHz -26.5 GHz, 30 MHz – 1 GHz)
(1AC) (3AC)
Mode : Tx BT LE 2480 MHz

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Distance Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg]	Remark
Hori.	50.577	QP	22.85	10.55	6.96	32.12	0.00	8.24	40.00	31.7	100	0	
Hori.	126.195	QP	22.57	13.29	7.49	32.05	0.00	11.30	43.50	32.2	100	0	
Hori.	167.751	QP	22.27	15.73	8.02	32.02	0.00	14.00	43.50	29.5	100	0	
Hori.	294.604	QP	22.12	13.21	8.69	31.92	0.00	12.10	46.00	33.9	100	0	
Hori.	2483.500	PK	62.68	27.52	14.14	40.81	2.45	65.98	73.90	7.9	160	132	
Hori.	4960.000	PK	55.82	31.45	6.50	41.65	2.45	54.57	73.90	19.3	130	139	
Hori.	7440.000	PK	46.48	36.57	8.26	41.36	2.45	52.40	73.90	21.5	150	0	
Hori.	9920.000	PK	45.06	38.58	9.43	40.66	2.45	54.86	73.90	19.0	150	0	
Vert.	123.300	QP	22.15	13.08	7.45	32.06	0.00	10.62	43.50	32.8	100	0	
Vert.	155.279	QP	22.48	15.13	7.99	32.03	0.00	13.57	43.50	29.9	100	0	
Vert.	313.863	QP	22.05	13.70	8.79	31.89	0.00	12.65	46.00	33.3	100	0	
Vert.	610.366	QP	21.60	19.02	10.06	31.82	0.00	18.86	46.00	27.1	100	0	
Vert.	2483.500	PK	60.29	27.52	14.14	40.81	2.45	63.59	73.90	10.3	150	242	
Vert.	4960.000	PK	53.96	31.45	6.50	41.65	2.45	52.71	73.90	21.2	177	184	
Vert.	7440.000	PK	47.64	36.57	8.26	41.36	2.45	53.56	73.90	20.3	150	0	
Vert.	9920.000	PK	45.44	38.58	9.43	40.66	2.45	55.24	73.90	18.7	150	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18 GHz)) - Gain(Amplifier) + Distance factor

Distance factor : 1 GHz - 13 GHz : $20\log(3.98\text{ m} / 3.0\text{ m}) = 2.45\text{ dB}$

13 GHz - 40 GHz : $20\log(1.0\text{ m} / 3.0\text{ m}) = -9.54\text{ dB}$

Average measurement value with duty factor

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Distance Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori.	2483.500	AV	40.80	27.52	14.14	40.81	3.96	2.45	48.06	53.90	5.8	*1)
Hori.	4960.000	AV	49.01	31.45	6.50	41.65	3.96	2.45	51.72	53.90	2.2	
Hori.	7440.000	AV	38.03	36.57	8.26	41.36	3.96	2.45	47.91	53.90	6.0	
Hori.	9920.000	AV	36.41	38.58	9.43	40.66	3.96	2.45	50.17	53.90	3.7	
Vert.	2483.500	AV	39.44	27.52	14.14	40.81	3.96	2.45	46.70	53.90	7.2	*1)
Vert.	4960.000	AV	47.09	31.45	6.50	41.65	3.96	2.45	49.80	53.90	4.1	
Vert.	7440.000	AV	38.04	36.57	8.26	41.36	3.96	2.45	47.92	53.90	6.0	
Vert.	9920.000	AV	36.38	38.58	9.43	40.66	3.96	2.45	50.14	53.90	3.8	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18 GHz)) - Gain(Amplifier) + Duty factor + Distance factor

Distance factor : 1 GHz - 13 GHz : $20\log(3.98\text{ m} / 3.0\text{ m}) = 2.45\text{ dB}$

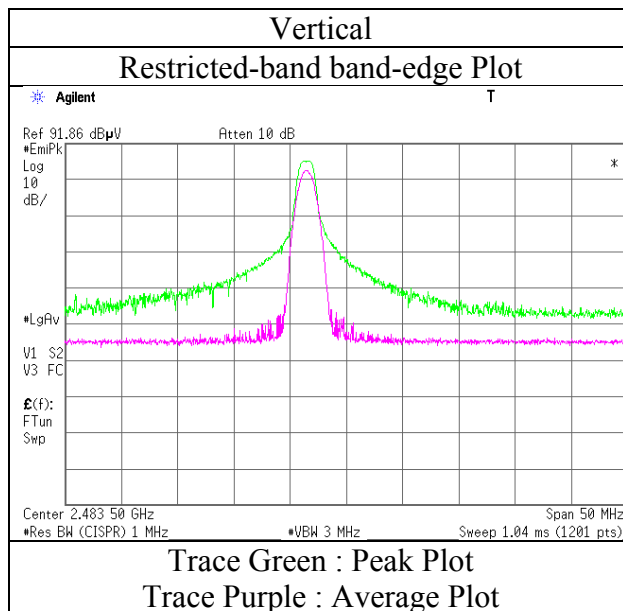
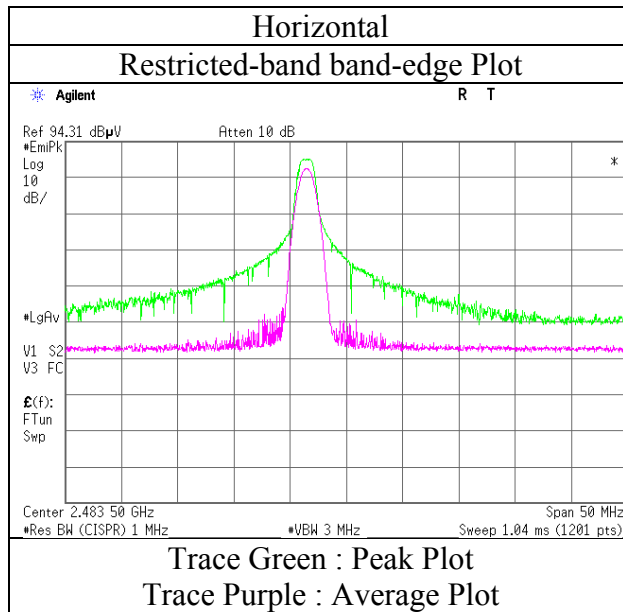
13 GHz - 40 GHz : $20\log(1.0\text{ m} / 3.0\text{ m}) = -9.54\text{ dB}$

Duty factor refer to "Duty factor Calculation chart" sheet.

*1) Not out of band emission (Leakage Power)

Radiated Spurious Emission **(Reference Plot for band-edge)**

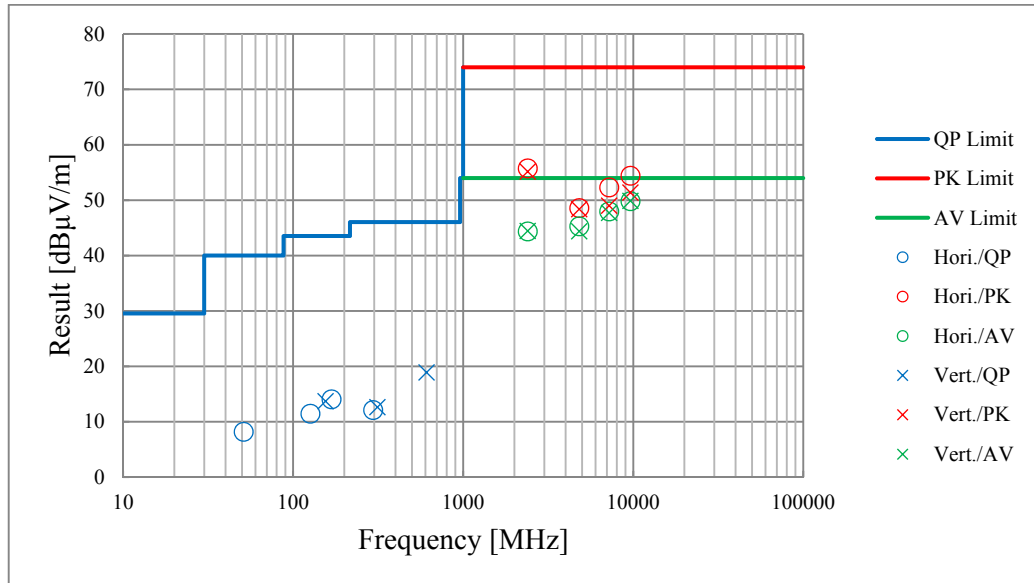
Test place : Shonan EMC Lab. No.1 Semi Anechoic Chamber
Report No. : 11822953S-A-R1
Date : June 24, 2017
Temperature / Humidity : 23 deg. C / 59 % RH
Engineer : Hiroyuki Morikawa
(1 GHz -13 GHz)
Mode : Tx BT LE 2480 MHz



* Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission **(Plot data, Worst case)**

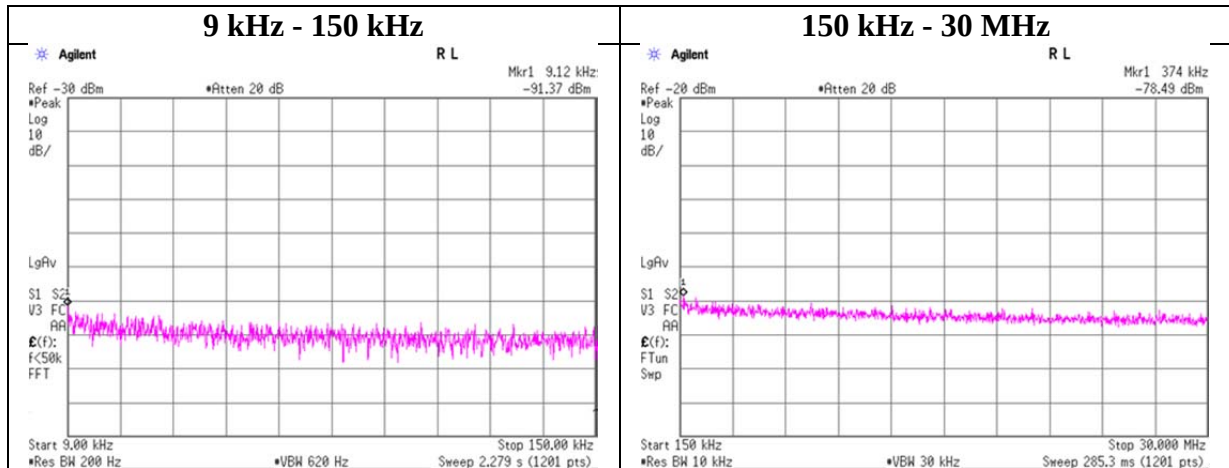
Test place	Shonan EMC Lab. No.1 & 3 Semi Anechoic Chamber	
Report No.	11822953S-A-R1	
Date	June 24, 2017	June 26, 2017
Temperature / Humidity	23 deg. C / 59 % RH	24 deg. C / 68 % RH
Engineer	Hiroyuki Morikawa (1 GHz -18 GHz) (1AC)	Yosuke Ishikawa (18 GHz -26.5 GHz, 30 MHz – 1 GHz) (3AC)
Mode	Tx BT LE 2402 MHz	



*These plots data contains sufficient number to show the trend of characteristic features for EUT.

Conducted Spurious Emission

Test place : Shonan EMC Lab. No.6 Shielded Room
Report No. : 11822953S-A-R1
Date : June 26, 2017
Temperature / Humidity : 23 deg. C / 53 % RH
Engineer : Kazutaka Takeyama
Mode : Tx BT LE 2402 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
9.12	-91.4	0.15	9.8	2.5	1	-78.9	300	6.0	-17.6	48.4	66.0	
374.00	-78.5	0.15	9.8	2.5	1	-66.0	300	6.0	-4.7	16.1	20.8	

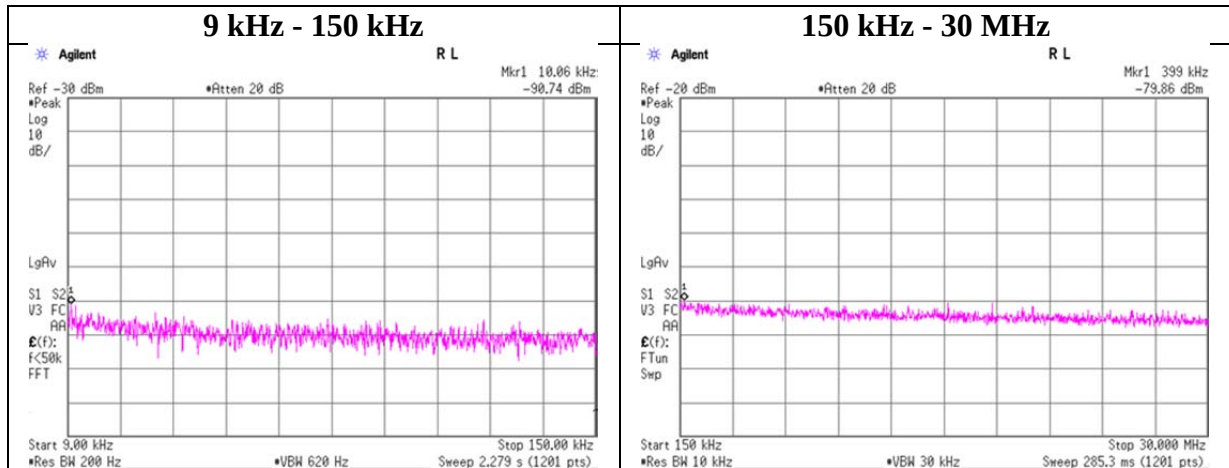
$E \text{ [dBuV/m]} = \text{EIRP [dBm]} - 20 \log (\text{Distance [m]}) + \text{Ground bounce [dB]} + 104.8 \text{ [dBuV/m]}$

$\text{EIRP [dBm]} = \text{Reading [dBm]} + \text{Cable loss [dB]} + \text{Attenuator Loss [dB]} + \text{Antenna gain [dBi]} + 10 * \log (N)$

N: Number of output

Conducted Spurious Emission

Test place : Shonan EMC Lab. No.6 Shielded Room
Report No. : 11822953S-A-R1
Date : June 26, 2017
Temperature / Humidity : 23 deg. C / 53 % RH
Engineer : Kazutaka Takeyama
Mode : Tx BT LE 2440 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
10.06	-90.7	0.15	9.8	2.5	1	-78.3	300	6.0	-17.0	47.5	64.5	
399.00	-78.5	0.15	9.8	2.5	1	-66.0	300	6.0	-4.7	15.5	20.2	

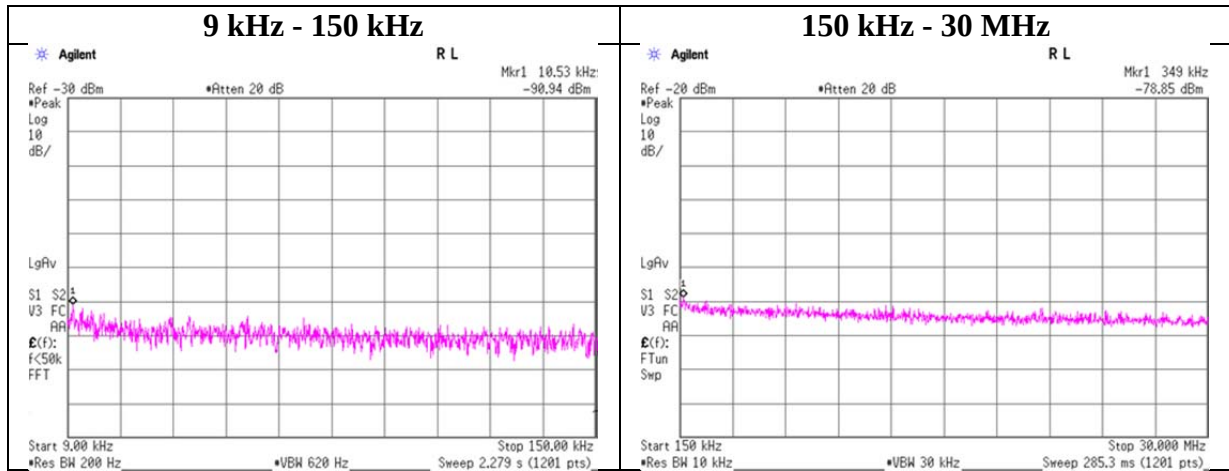
$E \text{ [dBuV/m]} = \text{EIRP [dBm]} - 20 \log (\text{Distance [m]}) + \text{Ground bounce [dB]} + 104.8 \text{ [dBuV/m]}$

$\text{EIRP [dBm]} = \text{Reading [dBm]} + \text{Cable loss [dB]} + \text{Attenuator Loss [dB]} + \text{Antenna gain [dBi]} + 10 * \log (N)$

N: Number of output

Conducted Spurious Emission

Test place	Shonan EMC Lab. No.6 Shielded Room
Report No.	11822953S-A-R1
Date	June 26, 2017
Temperature / Humidity	23 deg. C / 53 % RH
Engineer	Kazutaka Takeyama
Mode	Tx BT LE 2480 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
10.53	-90.9	0.15	9.8	2.5	1	-78.5	300	6.0	-17.2	47.1	64.3	
349.00	-78.9	0.15	9.8	2.5	1	-66.4	300	6.0	-5.1	16.7	21.8	

$E [dBuV/m] = EIRP [dBm] - 20 \log (Distance [m]) + Ground\ bounce [dB] + 104.8 [dBuV/m]$

$EIRP[dBm] = Reading [dBm] + Cable\ loss [dB] + Attenuator\ Loss [dB] + Antenna\ gain [dBi] + 10 * \log (N)$

N: Number of output

Power Density

Test place Shonan EMC Lab. No.6 Shielded Room
Report No. 11822953S-A-R1
Date June 26, 2017
Temperature / Humidity 23 deg. C / 53 % RH
Engineer Kazutaka Takeyama
Mode Tx

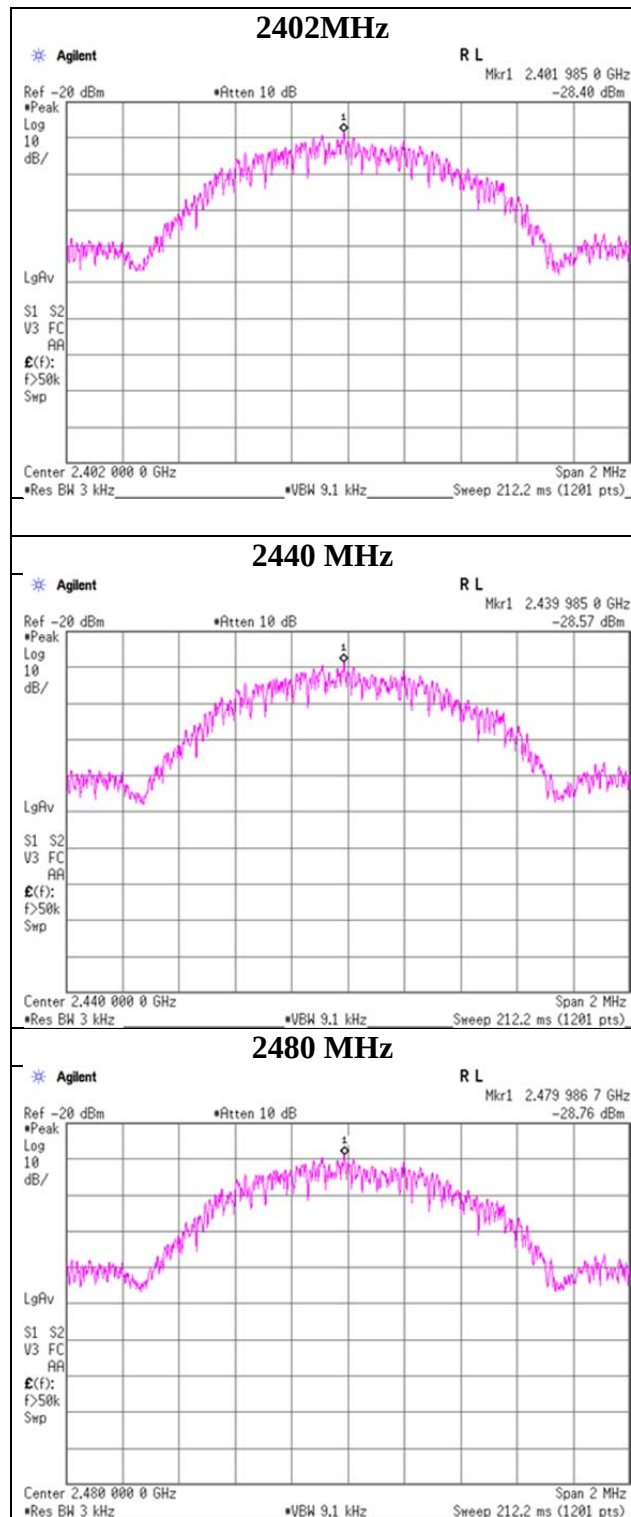
Freq.	Reading	Cable Loss	Atten. Loss	Result	Limit	Margin
[MHz]	[dBm]	[dB]	[dB]	[dBm]	[dBm]	[dB]
2402.00	-28.40	1.42	9.85	-17.13	8.00	25.13
2440.00	-28.57	1.43	9.84	-17.30	8.00	25.30
2480.00	-28.76	1.44	9.84	-17.48	8.00	25.48

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

*The equipment and cables were not used for factor 0 dB of the data sheets.

Power Density



UL Japan, Inc.

Shonan EMC Lab.

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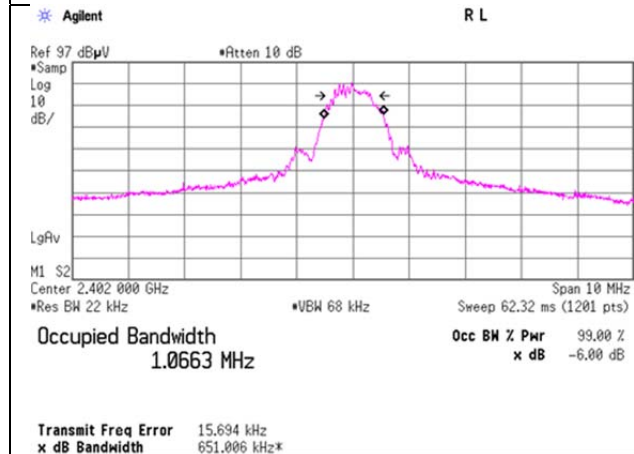
Facsimile : +81 463 50 6401

99%Occupied Bandwidth

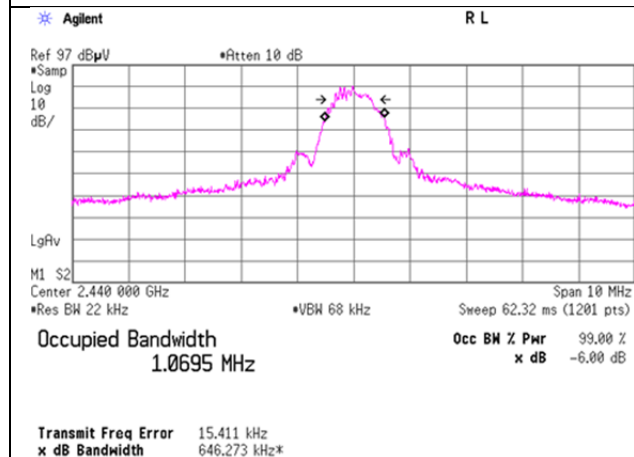
Test place Shonan EMC Lab. No.6 Shielded Room
Report No. 11822953S-A-R1
Date June 26, 2017
Temperature / Humidity 23 deg. C / 53 % RH
Engineer Kazutaka Takeyama
Mode Tx

BLE

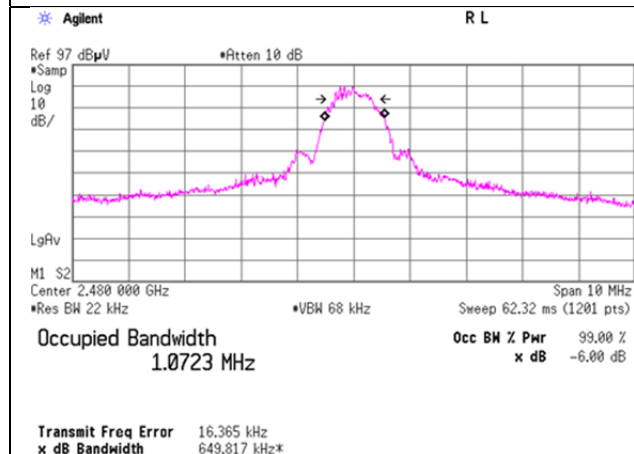
2402 MHz



2440 MHz



2480 MHz



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APPENDIX 2: Test instruments

Test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
SSA-02	Spectrum Analyzer	Agilent	E4448A	MY48250106	AT	2017/03/07 * 12
SCC-G13	Coaxial Cable	Suhner	SUCOFLEX 102	31599/2	AT	2017/03/23 * 12
SAT10-12	Attenuator	Weinschel Corp.	54A-10	81601	AT	2017/03/23 * 12
SOS-10	Humidity Indicator	A&D	AD-5681	4064561	AT	2016/10/12 * 12
SPM-07	Power Meter	Agilent	8990B	MY5100272	AT	2017/05/01 * 12
SPSS-04	Power sensor	Agilent	N1923A	MY5326009	AT	2017/05/01 * 12
SAF-04	Pre Amplifier	TOYO Corporation	TPA0118-36	1440489	RE	2017/03/17 * 12
SCC-G41	Coaxial Cable	Junkosha	MWX221-0100 ONFSNMS/B	1612S006	RE	2017/01/08 * 12
SCC-G06	Coaxial Cable	Junkosha	J12J102207-00	MAY-23-16-091	RE	2017/06/13 * 12
SCC-G23	Coaxial Cable	Suhner	SUCOFLEX 104	297342/4	RE	2017/05/08 * 12
SHA-01	Horn Antenna	Schwarzbeck	BBHA9120D	9120D-725	RE	2016/08/09 * 12
SOS-01	Humidity Indicator	A&D	AD-5681	4062555	RE	2016/10/12 * 12
KSA-08	Spectrum Analyzer	Agilent	E4446A	MY46180525	RE	2016/10/11 * 12
KJM-09	Measure	KOMELON	KMC-36	-	RE	-
SAEC-01(SVSWR)	Semi-Anechoic Chamber	TDK	SAEC-01(SVSWR)	1	RE	2016/07/24 * 12
COTS-SEMI-1	EMI Software	TSJ	TEPTO-DV(RE,CE,RFL,MF)	-	RE	-
SAT10-05	Attenuator(above1GHz)	Agilent	8493C-010	74864	RE	2016/11/07 * 12
SFL-02	Highpass Filter	MICRO-TRONICS	HPM50111	051	RE	2016/11/29 * 12
SAEC-03(NSA)	Semi-Anechoic Chamber	TDK	SAEC-03(NSA)	3	RE	2017/06/11 * 12
SBA-03	Biconical Antenna	Schwarzbeck	BBA9106	91032666	RE	2016/10/18 * 12
SLA-07	Logperiodic Antenna	Schwarzbeck	VUSLP9111B	196	RE	2017/01/26 * 12
SAT6-08	Attenuator	HIROSE ELECTRIC CO.,LTD.	AT-406(40)	-	RE	2016/08/04 * 12
SCC-C1/C2/C3/C4/C5/C10/SRSE-03	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhner/Suhner/Suhner/T OYO	8D2W/12DSFA/141PE/141PE/141PE/141PE/NS4906	-/0901-271(R F Selector)	RE	2017/04/07 * 12
SAF-03	Pre Amplifier	SONOMA	310N	290213	RE	2017/02/09 * 12
SOS-05	Humidity Indicator	A&D	AD-5681	4062518	RE	2016/10/12 * 12
SJM-02	Measure	KOMELON	KMC-36	-	RE	-
SSA-02	Spectrum Analyzer	Agilent	E4448A	MY48250106	RE	2017/03/07 * 12
STR-08	Test Receiver	Rohde & Schwarz	ESW44	101581	RE	2016/11/08 * 12
SHA-05	Horn Antenna	ETS LINDGREN	3160-09	LM4210	RE	2017/03/15 * 12
SCC-G20	Coaxial Cable	Junkosha	J12J102518-00	APR-15-15-003	RE	2017/04/20 * 12
SCC-G33	Coaxial Cable	Junkosha	MWX241-0100 0KMSKMS	-	RE	2017/04/20 * 12
SAF-09	Pre Amplifier	TOYO Corporation	HAP18-26W	00000018	RE	2016/09/27 * 12

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

RE: Radiated Emission test
AT: Antenna Terminal Conducted test

UL Japan, Inc.

Shonan EMC Lab.

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